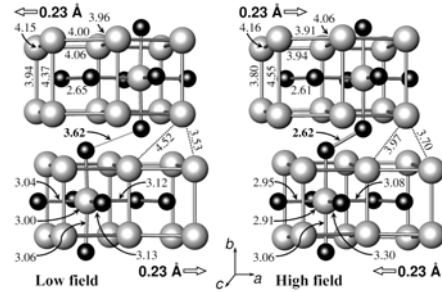


W0052

**Imaging Magnetic Field Induced Structural Transitions at the Atomic Level.** V.K. Pecharsky, Ya. Mudryk, K.A. Gschneidner, Jr., Ames Laboratory, Dept. of Materials Science and Engineering, Iowa State Univ., Ames, IA 50010, USA.

Temperature and/or pressure induced polymorphism is much more common compared to structural rearrangements triggered by a magnetic field. While the former is routinely probed *in situ* by temperature and pressure dependent powder diffraction, the most common tools employed in detecting magnetic field induced polymorphism remain bulk field-dependent measurements of the physical properties, e.g., the electrical resistance, magnetization and strain. On one hand, discontinuities in these macroscopic properties serve as suitable evidence of a structural phase transition, but on the other hand, they provide no clues about its atomic-scale mechanism. By successfully coupling a rotating anode powder diffractometer with a continuous-flow cryostat and a split-coil superconducting magnet we were able to obtain excellent Rietveld-quality powder diffraction data between 2.5 K and 315 K in 0 to 4 T magnetic fields. This allowed us to study the massive magnetic field-induced structural transformations in several polycrystalline compounds from the  $R_5\text{Si}_x\text{Ge}_{4-x}$  family, where R = lanthanide metal.



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